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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of	
Kazuya KAMON	Group Art Unit: 1756
Application No.: 09/320,946	Examiner: S. Mohamedulla
Filed: May 26, 1999	) )
For: PHOTOMASK, FABRICATION METHOD OF PHOTOMASK, AND FABRICATION METHOD OF SEMICONDUCTOR INTEGRATED CIRCUIT	PATELLE April 4 2001
PRELIMINARY AMENDMENT /STATEMENT	
Assistant Commissioner for Patents Washington, D.C. 20231	Date: April 4, 2001

This preliminary amendment is filed in order to facilitate processing in the above-identified application and is filed in response to the Advisory Action dated March 14, 2001 (Paper No. 8).

## **REMARKS**

This preliminary amendment is filed in order to respond to note no. 6 in the Advisory Action dated March 14, 2001. In particular, Applicant respectfully traverse the Examiner's statement "while *Hur* and *Lee* do not specifically teach chemical-mechanical polishing the phase shift film, it is an obvious variation of *Hur* or *Lee* to polish it as the references teach performing chemical-mechanical polishing on other areas of the mask. Applicant argues that *Hur* and *Lee* do not teach a reflection preventing film, however, they teach a light shading film". Applicant respectfully point out that a reflection preventing